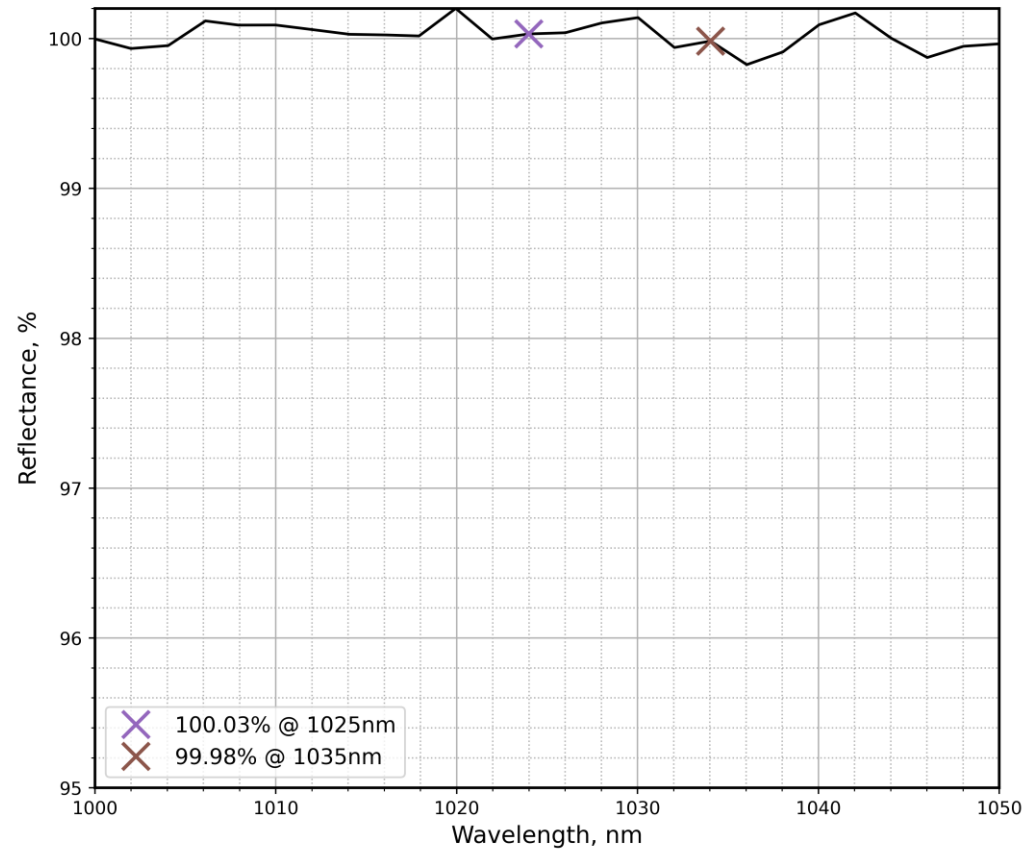


S1: HRsp>99.95% @ 1025 nm - 1035 nm, AOI=40-50 deg
S2: SCC



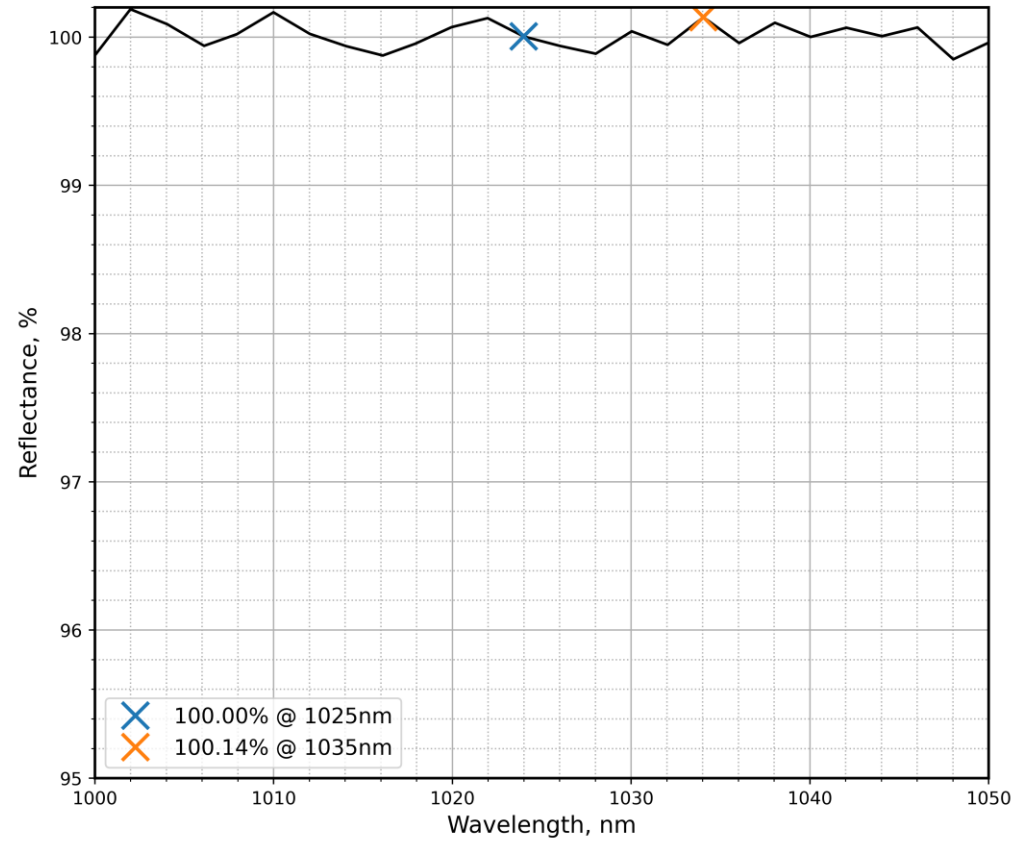
PO4342 Rs i40

Fig. 1.

SIDE MEASURED: S1 only (grinded witness sample)

COMMENTS: Margin of measurement error: +/-0.25%

S1: HRsp>99.95% @ 1025 nm - 1035 nm, AOI=40-50 deg
S2: SCC



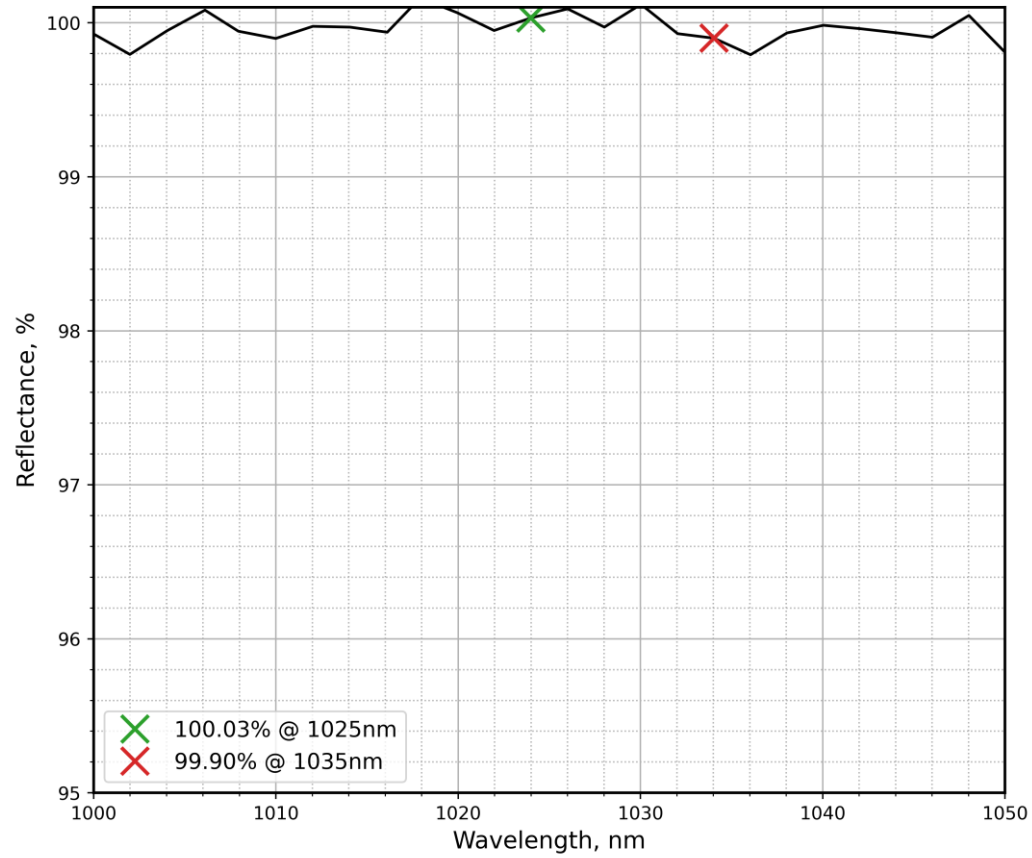
PO4342 Rp i40

Fig. 2.

SIDE MEASURED: S1 only (grinded witness sample)

COMMENTS: Margin of measurement error: +/-0.25%

S1: HRsp>99.95% @ 1025 nm - 1035 nm, AOI=40-50 deg
S2: SCC



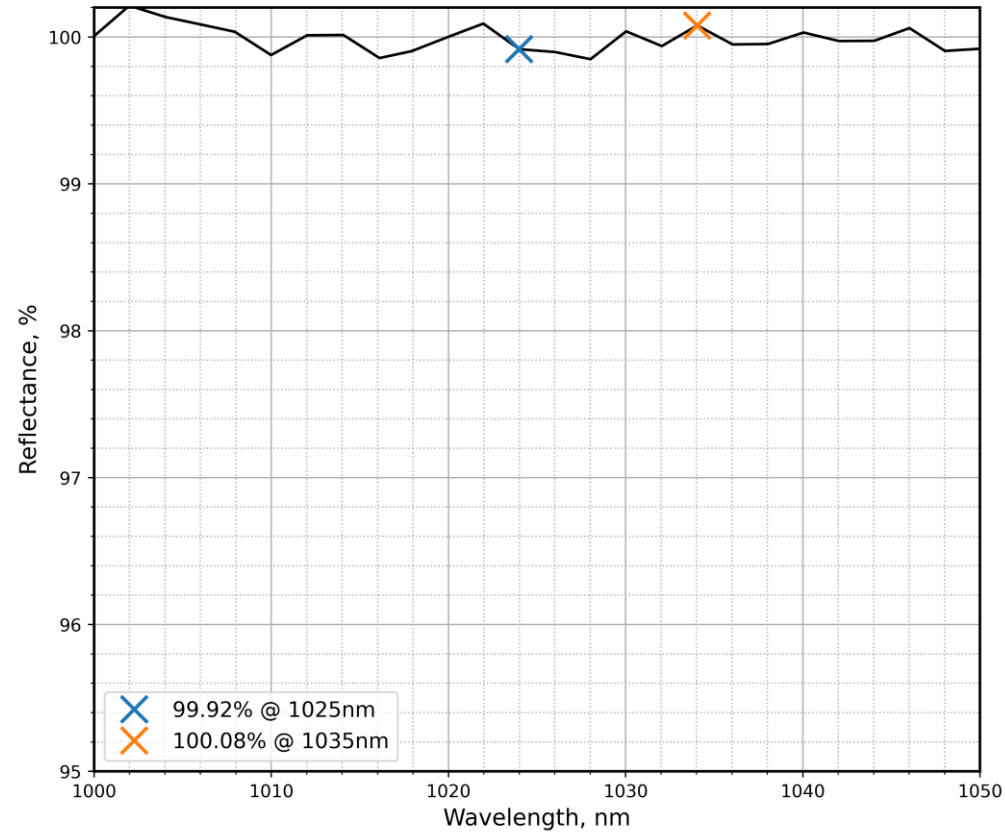
PO4342 Rs i50

Fig. 3.

SIDE MEASURED: S1 only (grinded witness sample)

COMMENTS: Margin of measurement error: +/-0.25%

S1: HRsp>99.95% @ 1025 nm - 1035 nm, AOI=40-50 deg
S2: SCC



PO4342 Rp i50

Fig. 4.

SIDE MEASURED: S1 only (grinded witness sample)

COMMENTS: Margin of measurement error: +/-0.25%